

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/772,311	LEE ET AL.	
Examiner	Art Unit	
EDMUND H. LEE	1732	

	SEARCHED		
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
east	9/4/2007	EHL
inventor		
264/272.14,272.15,272.17,161,328.9, 328.12		